Features

- Ideal Rewriteable Attribute Memory
- Simple Write Operation Self-Timed Byte Writes On-chip Address and Data Latch for SRAM-like Write Operation Fast Write Cycle Time - 1 ms 5-Volt-Only Nonvolatile Writes
- End of <u>Write Detection</u>
 <u>RDY/BUSY</u> Output
 DATA Polling
- High Reliability Endurance: 100,000 Write Cycles Data Retention: 10 Years Minimum
- Single 5-Volt Supply for Read and Write
- Very Low Power 30 mA Active Current 100 µA Standby Current

16K (2K x 8) PCMCIA Nonvolatile Attribute Memory

Description

The AT28C16-T is the ideal nonvolatile attribute memory: it is a low power, 5-volt-only byte writeable nonvolatile memory (E^2 PROM). Standby current is typically less than 100 µA. The AT28C16-T is written like a Static RAM, eliminating complex programming algorithms. The fast write cycle times of 1 ms, allow quick card reconfiguration in-system. Data retention is specified as 10 years minimum, precluding the necessity for batteries. Three access times have been specified to allow for varying layers of buffering between the memory and the PCMCIA interface.

The AT28C16-T is accessed like a Static RAM for read and write operations. During a byte write, the address and data are latched internally. Following the initiation of a write cycle, the device will go to a busy state and automatically write the latched data using an internal control timer. The device provides two methods for detecting the end of a write cycle; the RDY/BUSY output and DATA polling of I/O7.

Pin Configurations

Function	
Addresses	
Chip Enable	
Output Enable	
Write Enable	1
Data Inputs/Outputs	RD
Ready/Busy Output	1
No Connect	1
	Addresses Chip Enable Output Enable Write Enable Data Inputs/Outputs Ready/Busy Output

TSOP Top View

NC	ŌĒ	5	2	1	28 27 A10	
	A9	3		3	26 9 1/07	CE
A8	NC	9	4	5	24 ²⁵ 5 1/05	1/06
WE		9	6	Ũ	23 🖻	1/04
Y/BUSY	VCC	Ľ۵	8	7	22 21 E 1/03	GND
	NC	9	-	9	20 ₽ 1/02	
A7	A6	H	10	11	18 ¹⁹ E 1/00	1/01
A5		g	12		17 P	A0
A3	A4	Ł	14	13	16 15 A1	A2





Block Diagram



Absolute Maximum Ratings*

Temperature Under Bias55°C to +125°C
Storage Temperature65°C to +125°C
All Input Voltages (including N.C. Pins) with Respect to Ground
All Output Voltages with Respect to Ground0.6 V to Vcc +0.6 V
Voltage on $\overline{\text{OE}}$ and A9 with Respect to Ground

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Device Operation

READ: The AT28C16-T is accessed like a Static RAM. When \overline{CE} and \overline{OE} are low and \overline{WE} is high, the data stored at the memory location detemined by the address pins is asserted on the outputs. The outputs are put in a high impedance state whenever \overline{CE} or \overline{OE} is high. This dual-line control gives designers increased flexibility in preventing bus contention.

BYTE WRITE: Writing data into the AT28C16-T is similar to writing into a Static RAM. A low pulse on \overline{WE} or \overline{CE} input with \overline{OE} high and \overline{CE} or \overline{WE} low (respectively) initiates a byte write. The address is latched on the falling edge of \overline{WE} or \overline{CE} (whichever occurs last) and the data is latched on the rising edge of \overline{WE} or \overline{CE} (whichever occurs first). Once a byte write is started it will automatically time itself to completion. For the AT28C16-T the write cycle time is 1 ms maximum. Once a programming operation has been initiated and for the duration of twc, a read operation will effectively be a polling operation.

READY/BUSY: Pin 1 is an open drain READY/BUSY output that indicates the current status of the self-timed internal write cycle. READY/BUSY is actively pulled low during the write cycle and is released at the completion of the write. The open drain output allows OR-tying of several devices to a common interrupt input.

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 $\overline{\text{DATA}}$ POLLING: The AT28C16-T also provides $\overline{\text{DATA}}$ polling to signal the completion of a write cycle. During a write cycle, an attempted read of the the data being written results in the complement of that data for I/O7 (the other outputs are indeterminate). When the write cycle is finished, true data appears on all ouputs.

WRITE PROTECTION: Inadvertent writes to the device are protected against in the following ways: (a) V_{CC} sense— if V_{CC} is below 3.8 V (typical) the write function is inhibited; (b) V_{CC} power on delay— once V_{CC} has reached 3.8 V the device will automatically time out 5 ms (typical) before allowing a byte write; (c) Write Inhibit— holding any one of \overline{OE} low, \overline{CE} high or \overline{WE} high inhibits byte write cycles.

CHIP CLEAR: The contents of the entire memory of the AT28C16-T may be set to the high state by the Chip Clear operation. By setting \overline{CE} low and \overline{OE} to 12 V, the chip is cleared when a 10ms low pulse is applied to \overline{WE} .

DEVICE IDENTIFICATION: An extra 32 bytes of E^2 PROM memory are available to the user for device identification. By raising A9 to 12 V (± 0.5 V) and using address locations 7E0H to 7FFH the additional bytes may be written to or read from in the same manner as the regular memory array.

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D.C. and A.C. Operating Range

		AT28C16-15T	AT28C16-20T	AT28C16-25T
Operating	Com.	0°C - 70°C	0°C - 70°C	0°C - 70°C
Temperature (Case)	Ind.	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C
Vcc Power Supply		5 V ± 10%	5 V ± 10%	5 V ± 10%

Operating Modes

Mode	CE	ŌĒ	WE	I/O
Read	VIL	ViL	ViH	
Write ⁽²⁾	VIL	Ин	VIL	DIN
Standby/Write Inhibit	VIH	X ⁽¹⁾	X	High Z
Write Inhibit	X	х	ViH	
Write Inhibit	х	VIL	X	
Output Disable	Х	ViH	х	High Z
Chip Erase	VIL	V _H ⁽³⁾	ViL	High Z
otes: 1. X can be V_{IL} or V_{IH} .		3. $V_{\rm H} = 12.0 \text{ V} \pm$	0.5 V.	

2. Refer to A.C. Programming Waveforms.

D.C. Characteristics

Symbol	Parameter	Condition		Min	Max	Units
lLI	Input Load Current	$V_{IN} = 0 V$ to $V_{CC} + 1 V$			10	μΑ
llo	Output Leakage Current	VI/O = 0 V to VCC			10	μA
ISB1	V _{CC} Standby Current CMOS	$\overline{CE} = V_{CC}$ -0.3 V to V_{CC} + 1.0 V			100	μA
ISB2	Vcc Standby Current TTL	$\overline{CE} = 2.0 \text{ V}$ to $V_{CC} + 1.0 \text{ V}$	Com.		2	mA
	VCC Standby Current TTE	0L = 2.0 V 10 V(C + 1.0 V	Ind.		3	mA
lcc	Vcc Active Current	f = 5 MHz; lout = 0 mA	Com.		30	mA
		1 = 3 WHZ, 1001 = 0 HA	Ind.		45	mA
VIL	Input Low Voltage				0.8	V
VIH	Input High Voltage			2.0		V
Vol	Output Low Voltage	loL = 2.1 mA			.4	v
Voн	Output High Voltage	loн = -400 µA		2.4		V

Pin Capacitance $(f = 1 \text{ MHz}, T = 25^{\circ}\text{C})^{(1)}$

	Тур	Max	Units	Conditions
CIN	4	6	pF	VIN = 0 V
Соит	8	12	рF	Vout = 0 V

Note: 1. This parameter is characterized and is not 100% tested.





A.C. Read Characteristics

PCMCIA	Atmel		AT280	16-15T	AT280	:16-20T	AT280	16-25T	
Symbol	Symbol	Parameter	Min	Max	Min	Мах	Min	Max	Units
tc (R)	tRC	Read Cycle Time	150		200		250		ns
t _A (A)	tACC	Address Access Time		150		200		250	ns
ta (CE)	tce (1)	CE Access Time		150		200		250	ns
t _A (OE)	toe (2)	OE Access Time	0	75	0	80	0	100	ns
tEN (CE)	tLz (4)	Output Enable Time From CE	0		0		0		ns
t _{EN} (OE)	tolz (4)	Output Enable Time From OE	0		0		0	:	ns
tv (A)	toн	Output Hold Time	0		0		0		ns
	tDF (3,4)	Output Disable Time From CE	0	50	0	55	0	60	ns
tois (OE)	t _{DF} ^(3,4)	Output Disable Time From OE	0	50	0	55	0	60	ns

A.C. Read Waveforms^(1,2,3,4)



Notes:

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- 1. \overline{CE} may be delayed up to t_{ACC} t_{CE} after the address transition without impact on t_{ACC} .
- 2. \overline{OE} may be delayed up to t_{CE} t_{OE} after the falling edge of \overline{CE} without impact on t_{CE} or by t_{ACC} - t_{OE} after an address change without impact on t_{ACC}.

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- 3. t_{DF} is specified from \overline{OE} or \overline{CE} whichever occurs first $(C_L = 5 \text{ pF})$.
- 4. This parameter is characterized and is not 100% tested.

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PCMCIA Symbol	Atmel Symbol	Parameter	Min	Max	Units
ts∪ (A)	tas	Address Setup Time	10	-	ns
ts∪ (OE-WE)	toes	Output Disable Time To WE	10		ns
tsu (CE-WE)	tcs	Chip Enable Time To WE	0		ns
tw (WE)	twp	Write Enable Pulse Width	100	1000	ns
tsu (D-WEH)	tos	Data Setup To WE High	50		ns
t _H (A)	tан	Address Hold Time From WE	50		ns
t _H (D)	toн	Data Hold Time From WE High	10		ns
t _H (OE-WE)	toeh	Output Enable Hold Time From WE High	10		ns
t _H (CE-WE)	tCH	Chip Enable Hold Time From WE High	0		ns
t _D (B)	tDB	Delay From WE High To BUSY Asserted		50	ns
tc (W)	twc	Write Cycle Time		1	ms

A.C. Write Characteristics

A.C. Write Waveforms









Data Polling Waveforms



Note: Data Polling A.C. Timing Characteristics are the same as the A.C. Read Characteristics.

Chip Erase Waveforms



$$\begin{split} t_S &= t_H = 1 \; \mu \text{sec (min.)} \\ t_W &= 10 \; \text{msec (min.)} \\ V_H &= 12.0 \pm 0.5 \; V \end{split}$$



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tacc	lcc	(mA)	Ordening Code	Bashasa	Output In D
(ns)	Active	Standby	Ordering Code	Package	Operation Range
150	30	0.1	AT28C16-15TC	28T	Commercial (0°C to 70°C)
150	45	0.1	AT28C16-15TI	28T	Industrial (-40°C to 85°C)
200	30	0.1	AT28C16-20TC	28T	Commercial (0°C to 70°C)
200	45	0.1	AT28C16-20TI	28T	Industrial (-40°C to 85°C)
250	30	0.1	AT28C16-25TC	28T	Commercial (0°C to 70°C)
250	45	0.1	AT28C16-25TI	28T	Industrial (-40°C to 85°C)

Ordering Information⁽¹⁾

Note: 1. See Valid Part Number table below.

Valid Part Numbers

The following table lists standard Atmel products that can be ordered.

Device Numbers	Speed	Package and Temperature Combinations
AT28C16	12	ТС, ТІ
AT28C16	15	TC, TI
AT28C16	20	TC, TI
AT28C16	25	TC, TI

	Package Type
28T	28 Lead, Plastic Thin Small Outline Package (TSOP)

